

阅读申明

- 1.本站收集的数据手册和产品资料都来自互联网，版权归原作者所有。如读者和版权方有任何异议请及时告之，我们将妥善解决。
- 2.本站提供的中文数据手册是英文数据手册的中文翻译，其目的是协助用户阅读，该译文无法自动跟随原稿更新，同时也可能存在翻译上的不当。建议读者以英文原稿为参考以便获得更精准的信息。
- 3.本站提供的产品资料，来自厂商的技术支持或者使用者的心得体会等，其内容可能存在描述上的差异，建议读者做出适当判断。
- 4.如需与我们联系，请发邮件到marketing@iczoom.com，主题请标有“数据手册”字样。

Read Statement

1. The datasheets and other product information on the site are all from network reference or other public materials, and the copyright belongs to the original author and original published source. If readers and copyright owners have any objections, please contact us and we will deal with it in a timely manner.
2. The Chinese datasheets provided on the website is a Chinese translation of the English datasheets. Its purpose is for reader's learning exchange only and do not involve commercial purposes. The translation cannot be automatically updated with the original manuscript, and there may also be improper translations. Readers are advised to use the English manuscript as a reference for more accurate information.
3. All product information provided on the website refer to solutions from manufacturers' technical support or users the contents may have differences in description, and readers are advised to take the original article as the standard.
4. If you have any questions, please contact us at marketing@iczoom.com and mark the subject with "Datasheets" .

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC74HC173AP, TC74HC173AF

QUAD D - TYPE REGISTER (3 - STATE)

The TC74HC173A is a high speed CMOS D - TYPE REGISTER fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

It consists a 4 - bit register consisting of D - type flip - flops and 3 - state buffers. The four flip - flops are controlled by a common clock input (CK) and a common clear input (CLR).

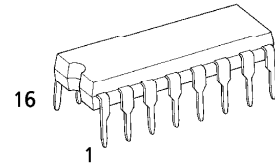
Signals applied to the data inputs (D1~D4) are stored in the respective flip - flops on the positive going transition of CK when clock control inputs (G1, G2) are held low.

The clear function is asynchronous to CK and active on a high level. The stored data are enabled to each outputs when output control inputs (M, N) are held low, else the outputs are high impedance state.

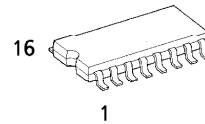
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

FEATURES :

- High Speed..... $f_{MAX} = 47\text{MHz}(\text{typ.})$ at $V_{CC} = 5\text{V}$
- Low Power Dissipation..... $I_{CC} = 4\mu\text{A}(\text{Max.})$ at $T_a = 25^\circ\text{C}$
- High Noise Immunity..... $V_{NIH} = V_{NIL} = 28\% V_{CC} (\text{Min.})$
- Output Drive Immunity..... 15 LSTTL Loads
- Symmetrical Output Impedance... $|I_{OH}| = I_{OL} = 6\text{mA}(\text{Min.})$
- Balanced Propagation Delays..... $t_{pLH} \approx t_{pHL}$
- Wide Operating Voltage Range... $V_{CC} (\text{opr.}) = 2\text{V} \sim 6\text{V}$
- Pin and Function Compatible with 74LS173

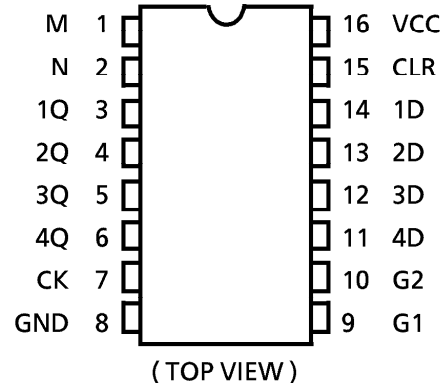


P (DIP16-P-300-2.54A)
Weight : 1.00g (Typ.)

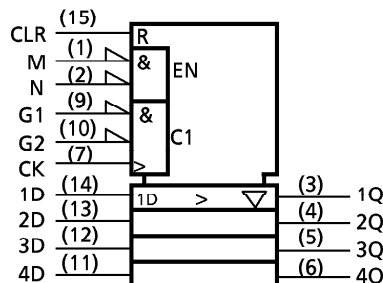


F (SOP16-P-300-1.27)
Weight : 0.18g (Typ.)

PIN ASSIGNMENT



IEC LOGIC SYMBOL



961001EBA2

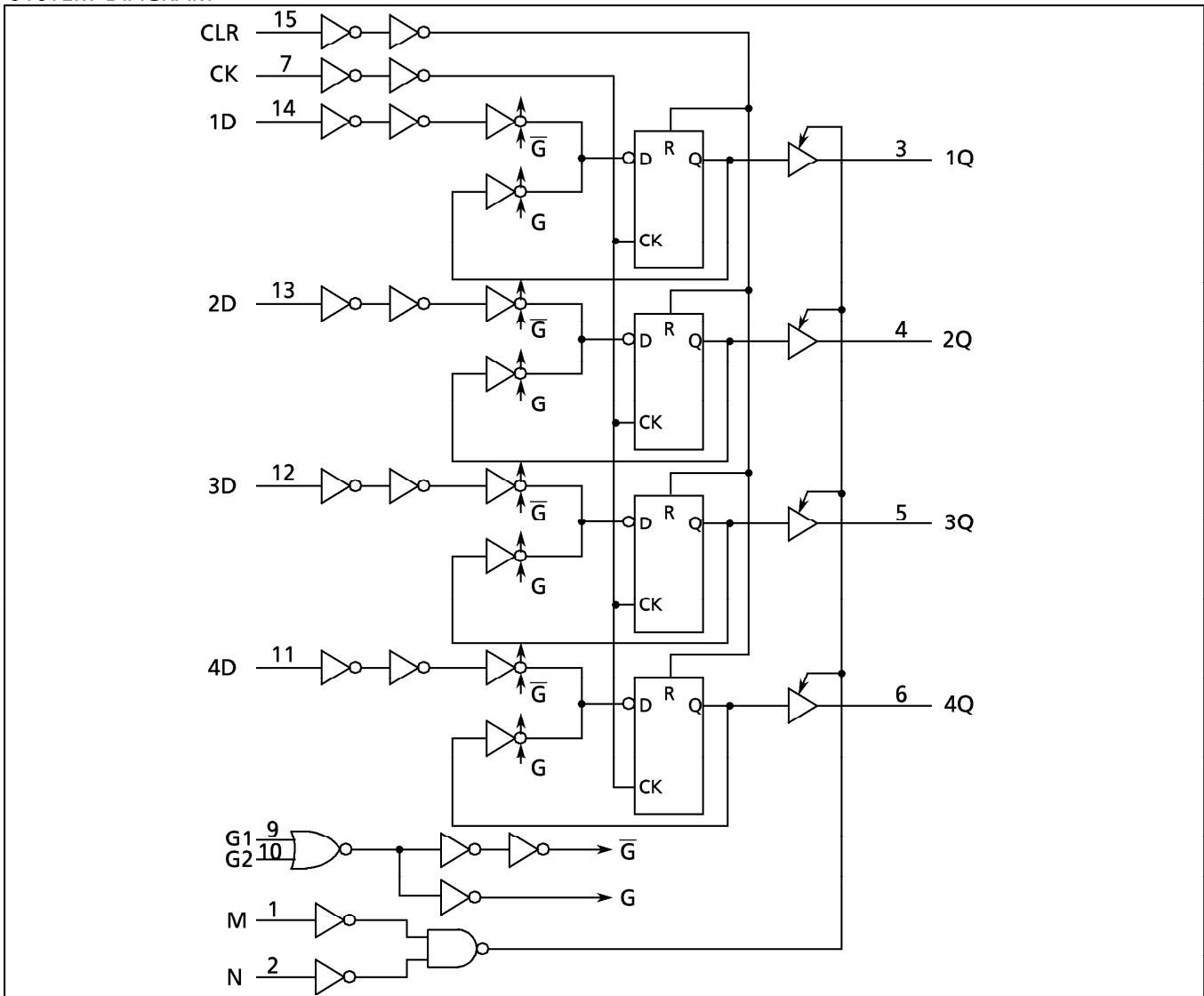
● TOSHIBA is continually working to improve the quality and the reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to observe standards of safety, and to avoid situations in which a malfunction or failure of a TOSHIBA product could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent products specifications. Also, please keep in mind the precautions and conditions set forth in the TOSHIBA Semiconductor Reliability Handbook.

TRUTH TABLE

CLR	CK	DATA INABLE		Dn	OUTPUT CONTROL		Qn
		G1	G2		M	N	
X	X	X	X	X	H	X	Z
X	X	X	X	X	X	H	Z
H	X	X	X	X	L	L	L
L		X	X	X	L	L	Q0
L		H	X	X	L	L	Q0
L		X	H	X	L	L	Q0
L		L	L	H	L	L	H
L		L	L	L	L	L	L

H : Don't Care
Z : High Impedance

SYSTEM DIAGRAM



961001EBA2'

- The products described in this document are subject to foreign exchange and foreign trade control laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	-0.5~7	V
DC Input Voltage	V_{IN}	-0.5~ $V_{CC} + 0.5$	V
DC Output Voltage	V_{OUT}	-0.5~ $V_{CC} + 0.5$	V
Input Diode Current	I_{IK}	± 20	mA
Output Diode Current	I_{OK}	± 20	mA
DC Output Current	I_{OUT}	± 35	mA
DC V_{CC} / Ground Current	I_{CC}	± 75	mA
Power Dissipation	P_D	500 (DIP)* / 180 (SOP)	mW
Storage Temperature	T_{stg}	-65~150	°C

*500mW in the range of $T_a = -40^{\circ}\text{C} \sim 65^{\circ}\text{C}$. From $T_a = 65^{\circ}\text{C}$ to 85°C a derating factor of $-10\text{mW}/^{\circ}\text{C}$ shall be applied until 300mW.

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	2~6	V
Input Voltage	V_{IN}	0~ V_{CC}	V
Output Voltage	V_{OUT}	0~ V_{CC}	V
Operating Temperature	T_{opr}	-40~85	°C
Input Rise and Fall Time	t_r, t_f	0~ 1000 ($V_{CC} = 2.0\text{V}$) 0~ 500 ($V_{CC} = 4.5\text{V}$) 0~ 400 ($V_{CC} = 6.0\text{V}$)	ns

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	V_{CC} (V)	$T_a = 25^{\circ}\text{C}$			$T_a = -40 \sim 85^{\circ}\text{C}$		UNIT	
				MIN.	TYP.	MAX.	MIN.	MAX.		
High - Level Input Voltage	V_{IH}		2.0	1.50	—	—	1.50	—	V	
			4.5	3.15	—	—	3.15	—		
			6.0	4.20	—	—	4.20	—		
Low - Level Input Voltage	V_{IL}		2.0	—	—	0.50	—	0.50	V	
			4.5	—	—	1.35	—	1.35		
			6.0	—	—	1.80	—	1.80		
High - Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -20\mu\text{A}$	2.0	1.9	2.0	—	1.9	V	
				4.5	4.4	4.5	—	4.4		—
				6.0	5.9	6.0	—	5.9		—
High - Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -6\text{ mA}$ $I_{OH} = -7.8\text{mA}$	4.5	4.18	4.31	—	4.13	V	
				6.0	5.68	5.80	—	5.63		—
				6.0	—	—	—	—		—
Low - Level Output Voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 20\mu\text{A}$	2.0	—	0.0	0.1	—	0.1	V
				4.5	—	0.0	0.1	—	0.1	
				6.0	—	0.0	0.1	—	0.1	
Low - Level Output Voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 6\text{ mA}$ $I_{OL} = 7.8\text{mA}$	4.5	—	0.17	0.26	—	0.33	V
				6.0	—	0.18	0.26	—	0.33	
				6.0	—	—	—	—	—	
3 - State Output Off - State Current	I_{oz}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND	6.0	—	—	± 0.5	—	± 5.0	μA	
Input Leakage Current	I_{IN}	$V_{IN} = V_{CC}$ or GND	6.0	—	—	± 0.1	—	± 1.0		
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND	6.0	—	—	4.0	—	40.0		

TIMING REQUIREMENTS (Input $t_r = t_f = 6\text{ns}$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C		UNIT
			V _{CC} (V)	TYP.	LIMIT	LIMIT		
Minimum Pulse Width (CK)	$t_{W(L)}$ $t_{W(H)}$		2.0	—	75	95		ns
			4.5	—	15	19		
			6.0	—	13	16		
Minimum Pulse Width (CLR)	$t_{W(H)}$		2.0	—	75	95		
			4.5	—	15	19		
			6.0	—	13	16		
Minimum Set-up Time (G1, G2)	t_s		2.0	—	100	125		
			4.5	—	20	25		
			6.0	—	17	21		
Minimum Set-up Time (D)	t_s		2.0	—	75	95		
			4.5	—	15	19		
			6.0	—	13	16		
Minimum Hold Time (G1, G2, D)	t_h		2.0	—	0	0		
			4.5	—	0	0		
			6.0	—	0	0		
Minimum Removal Time (CLR)	t_{rem}		2.0	—	5	5		
			4.5	—	5	5		
			6.0	—	5	5		
Clock Frequency	f		2.0	—	9	7		
			4.5	—	43	34		
			6.0	—	51	40		

AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 6\text{ns}$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C		UNIT		
			CL (pF)	V _{CC} (V)	MIN.	TYP.	MAX.		MIN.	MAX.
Output Transition Time	t_{TLH} t_{THL}		50	2.0	—	20	60	—	75	ns
				4.5	—	6	12	—	15	
				6.0	—	5	10	—	13	
Propagation Delay Time (CK—Q)	t_{PLH} t_{PHL}		50	2.0	—	50	115	—	145	
				4.5	—	15	23	—	29	
				6.0	—	12	20	—	25	
			150	2.0	—	65	155	—	195	
				4.5	—	20	31	—	39	
				6.0	—	16	26	—	33	
Propagation Delay Time (CLR—Q)	t_{PHL}		50	2.0	—	50	115	—	145	
				4.5	—	15	23	—	29	
				6.0	—	12	20	—	25	
			150	2.0	—	63	155	—	195	
				4.5	—	20	31	—	39	
				6.0	—	16	26	—	33	
Output Enable time	t_{PzL} t_{PzH}	$R_L = 1\text{k}\Omega$	50	2.0	—	50	115	—	145	
				4.5	—	15	23	—	29	
				6.0	—	12	20	—	25	
			150	2.0	—	63	115	—	195	
				4.5	—	20	31	—	39	
				6.0	—	16	26	—	33	
Output Disable time	t_{PLZ} t_{PHZ}	$R_L = 1\text{k}\Omega$	50	2.0	—	36	135	—	170	
				4.5	—	17	27	—	34	
				6.0	—	15	23	—	29	
Maximum Clock Frequency	f_{MAX}		50	2.0	9	20	—	7	MHz	
				4.5	43	67	—	34		
				6.0	51	84	—	40		
Input Capacitance	C_{IN}				—	5	10	pF		
Output Capacitance	C_{OUT}				—	10	—			
Power Dissipation Capacitance	$C_{PD}(1)$				—	45	—			

Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

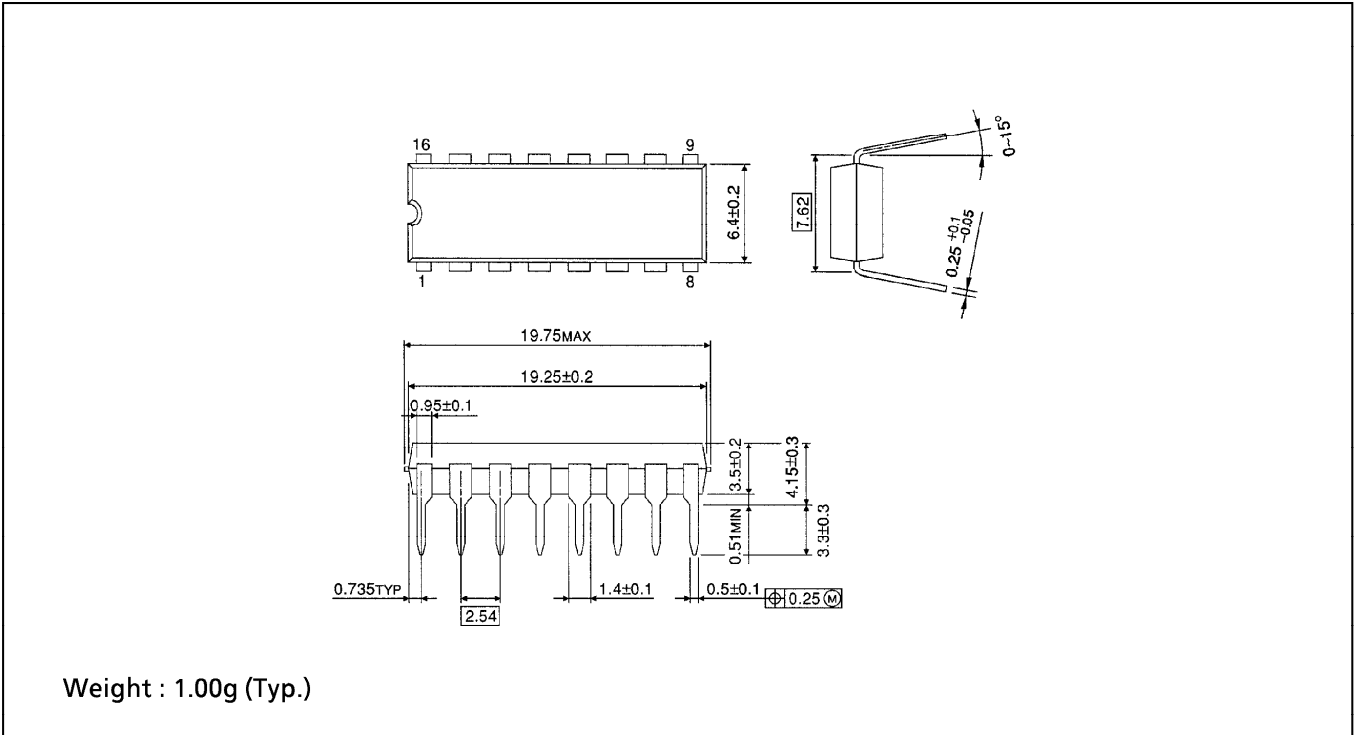
$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

And the total C_{PD} when n pcs of Flip Flop operate be gained by the following equation :

$$CPD(\text{total}) = 28 + 17 \cdot n$$

DIP 16PIN OUTLINE DRAWING (DIP16-P-300-2.54A)

Unit in mm



SOP 16PIN (200mil BODY) OUTLINE DRAWING (SOP16-P-300-1.27)

Unit in mm

